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X-ray and neutron sensitivity of imaging plates

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ABSTRACT

Periodic sensitivity calibration of imaging plates (IP) is crucial for quantitative understanding of x-ray data obtained at the National Ignition Facility (NIF). To test the x-ray sensitivity of the IPs and the scanners, we developed an x-ray exposure station based on radioactive isotopes (55Fe, 109Cd, and 241Am). This apparatus provides a convenient setup for a periodical test of the IP's and the scanners. On NIF implosion experiments with deuterium-tritium mixture fuel, the neutrons produced in the capsule hit the imaging plates and impose background signal. Therefore it is also important to know the neutron sensitivity of the IPs. The sensitivity for 14 MeV neutrons was measured on high neutron yield shots at the OMEGA laser facility. The measured sensitivities were compared with the results of Monte Carlo simulations.

Keywords: imaging plate, x-ray imaging, neutron background, MCNP, MCNPX

INTRODUCTION

An imaging plate (IP) is a phosphor which has a signal-storage capability [1]. Due to its immunity to electric-magnetic-interference, IPs have been used in various laser-plasma experiments [2,3,4,5]. When an IP is exposed to ionizing radiation, electrons excited in the phosphor (BaFBr:Eu) are trapped by color centers. When the plate is scanned with a laser beam (650nm), those trapped electrons are re-excited and cause photo-stimulated luminescence (~390 nm) by recombination [6]. Each type of IP has a different composition and physical thickness. The readout efficiency of the stored signal also depends on laser power, spot size, and scanning speed of the scanner. A signal fading due to thermal excitation of trapped carrier also affects the sensitivity of IPs. To keep the consistency, the sensitivity calibration has to be done with the same conditions of the actual usage.

X-RAY EXPOSURE STATION

Fig. 1 (a) is the exploded view of the x-ray exposure station. To minimize leakage of the radiation, most parts of the station are made of tungsten alloy. The station can hold up to 5 radioactive isotopes (RI). Currently it has 3 sources. For reduction of fluorescence from the tungsten alloy parts, the pockets for the RI sources have 5mm apertures at the bottom. The duration of exposure is controlled by the sliding shutter. To have similar exposure from sources which have different activities, users can adjust the distance between the source to the IP (13.48mm, 23.48mm or 33.4mm). Imaging plates were inserted to the slot below the filter pocket. In order to reduce the exposure of lower energy x-ray lines from the 241Am source (L fluorescence lines from Np on 13.9, 17.8 and 20.8 keV), a 2mm thick aluminum filter was installed in the filter pocket. The diameter of the active area of these sources (Eckert& Ziegler Type M) should be less than 3 mm. However we found the active area of those sources are larger than 5mm. Therefore, we measured the fraction of the source activities inside the 5mm aperture and used that for estimation of the x-ray photon fluence at the IP. Table 1 shows the details of this experiment. The setup parameters of the IP scanner are summarized on the table 2.

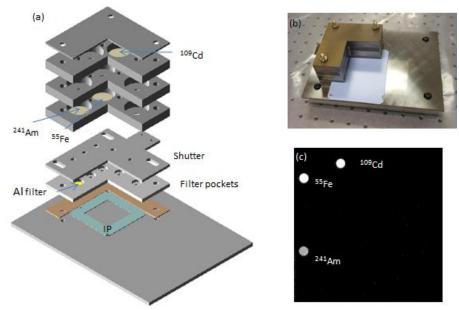


Fig. 1. Exploded view of the exposure station (a), photo during x-ray exposure (b), scanned data (c).

Table 1. Summary of the x-ray sensitivity calibration

Source	55Fe	109Cd	241Am
Serial No	1468-874	1531-2-1	1531-2-2
Activity as of 5/14/2012 [kBq]	2659	2676	368
Distance between source and IP (mm)	13.8	33.7	13.8
Duration of exposure (sec)	300	300	300
Time from start of exposure to scan (min)	17.52, 52.0, 52.67, 20.77	17.52, 52.0, 52.67, 20.77	17.52, 52.0, 52.67, 20.77
Filter material	Air	Air	Air +Al 2mm
Transmission though filter	95.8%	99.7%	85.8%
Fraction of activity in 5mm aperture	61.5%	74.8%	98.9%
X-ray energy (keV)	5.888, 5.899, 6.49	21.99, 22.163, 24.912, 24.943, 25.455	59.541
Photons per decay	0.27725	1.0221	0.359
Photon fluence (photons/mm ²)	5.68×10^4	4.30×10^4	1.41×10^4
Averaged signal (PSL/mm ²) *	78.4	66.4	12.52
Sensitivity (PSL/photon)	1.38×10 ⁻³	1.54×10 ⁻³	0.888×10 ⁻³

^{*}The results of the 4 samples were averaged after the fade correction (equivalent to the signal of the plates which scanned 20min from the start of exposure).

Table 2. Setup the IP scanner used for the x-ray sensitivity calibration

Parameters	Value		
IP Type	BAS SR (S/N 5x440024)		
Scanner	FUJIFILM FLA 7000 S/N		
	7662179		
Pixel Size	25 μm		
Pixel Depth	16 bit		
Sensitivity	4000		
Latitude	5		
Shading data*	IP_2009-10-06T11:27:54		

^{*}Name of the shading data file is useful for tracing of service/calibration date of the scanner

MONTE CARLO MODELING OF THE X-RAY SENSITIVITY

In order to understand the physics which governs the spectral sensitivity, we did numerical modeling of the imaging plate by using MCNPX [7]. Table 3 summarizes the material composition of the imaging plate assumed in the MCMPX model. Similar to other radiation detectors, the strength of the imaging plate signal is proportional to the energy deposited in the phosphor layer, and hence it is important to calculate how much energy is deposited in the phosphor layer.

Interactions of x-ray photons in the imaging plate can be described as follows. When x-ray photon energy is below 100 keV, the photoelectric absorption is dominant. In this region, it is important to calculate how much energy escapes the phosphor region as x-ray fluorescence. For example, when a 40keV photon is absorbed by k-shell of a Ba atom, ~37.4 keV of photon energy is used for ionization of the atom and the kinetic energy given to the photo electron is about 2.6 keV. Then the atom captures an electron from surroundings and emits several fluorescence photons or Auger electrons. Some fraction of the fluorescence photons escapes the phosphor without depositing energy in the phosphor (i.e. Fluorescence loss). When x-ray energy is higher than 100 keV, the contribution of Compton recoil is getting more important. In this energy region, the stopping range of the Compton electrons exceeds the thickness of the phosphor layer (~34mg/cm²) and they escape with depositing part of their kinematic energy in the phosphor (i.e. Electron escape). In order to include those deficiencies, the MCNPX was configured to track both photons and electrons (MODE P E). The signal strength was estimated by calculating energy deposited by electrons generated during photon collisions (tally6:e).

Another important mechanism which affects the spectral sensitivity is a depth-dependent readout efficiency of the laser scanner. Low energy x-ray photons (below few keV) are absorbed in the shallow surface of the phosphor and higher energy photons (over 20keV) penetrate through and excite the entire volume of the phosphor. When we scan the plate with laser light, the readout efficiency of the deep layer is lower than that on the shallow surface because of the diffusive transport of visible light in the phosphor. It should be noted that not only the laser light (650nm) but also the photostimulated luminescence signal (~390 nm,) is scattered by the granular structure of the phosphor. Therefore due to this depth effect, sensitivity for high x-ray energy should be reduced compared that for the lower energy x-ray. Detailed transport of the laser light and the photo-stimulated luminescence in the phosphor was described by M. Thoms in reference 8. For ease of calculation, we model the layer dependent readout efficiency as,

$$\eta(z,\lambda) = \exp(-z/L) \tag{1}$$

where z is the depth from the phosphor surface, L is the characteristic depth of the readout. In order to account for the depth effect, the phosphor layer in the MCNPX model is divided into 6 layers and the sensitivity of the entire plate is calculated as,

$$\xi_{total}(hv) = \frac{1}{W} \int_0^d \eta(z, L) \frac{dE(z, hv)}{dz} dz \quad (2),$$

where dE/dz is the energy deposition in the phosphor per incident photon calculated by MCNPX, d is the thickness of the phosphor (112 μ m), and W is energy deposition (at the shallow surface) which corresponds to the scanner readout of 1 PSL. Figure 2 shows the comparison of experimental data and the model calculated by Eq. (2). We fit the experimental data points by adjusting W and L. All the experimental data points were consistently explained by the model when W=4.12 MeV and L = 60 μ m.

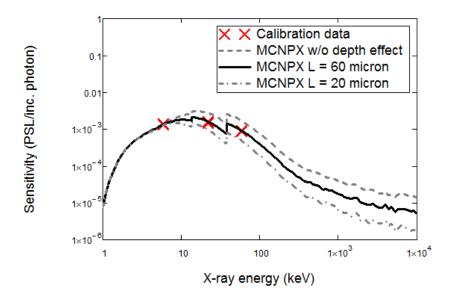


Fig. 2. Comparison of experimental data and MCNPX model. The MCNPX model showed good agreement with the experiment when W=4.12 MeV and $L=60\mu m$.

Table 3. Material composition of the BAS SR plate used in the MCNPX calculation

Layer	Composition	Thickness		
	(Atomic ratio)	(mg/cm ²)		
Protective coat	H-8, C-10, O-4	1.192		
Phosphor	Ba-1, F-1, Br-1, C-2.364, H-3.547, N-	34.384		
	0.591, O-0.296			
Undercoat	H-8, C-10, O-4	1.676		
Base	H-8, C-10, O-4	26.543		
Ferrite gum	Mn-1, Fe-2, O-4, C-3.02, H-4.832	24.0		
Back protective	H-8, C-10, O-4	3.493		

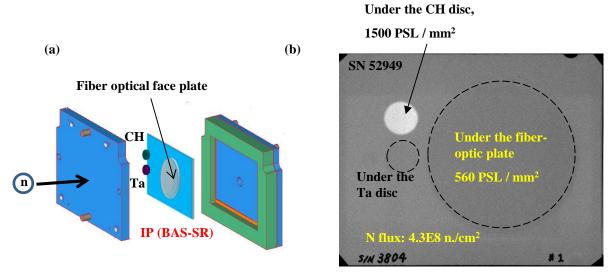


Fig. 3. Experimental setup of the neutron sensitivity measurement (a). Typical data after neutron exposure (b).

NEUTRON SENSITIVITY MEASURMENT

The neutron sensitivity of the IP (BAS SR plate) was measured at the OMEGA laser facility at the University of Rochester [9]. Neutrons (14 MeV) produced in the imploded capsules were used for excitation of the phosphor. Figure 3 shows the experimental setup. The imaging plate was enclosed in a light-tight cassette made of aluminum alloy and located on distance R=43.2cm from the target chamber center. Total neutron yield in the imploded plasma (Yn) was monitored by absolutely calibrated time-of-flight scintillation detectors [10]. Neutron fluence ϕ at the IP cassette was estimated as $\phi = Yn/(4\pi R^2)$. The imploded capsules produce x-ray background also. To confirm the excitation of the phosphor is dominated by the neutron excitation and contribution of hard x-ray background is small, we covered part of the IP with thick high-Z material (a 0.8mm thick tantalum disc and an 8mm thick fiber-optic faceplate made of lead glass). A 1mm thick plastic resin (CH) disc was used to convert the neutrons to the recoiled protons and enhance the sensitivity under the disc. Table 4 summarizes setup parameters of the IP scan.

Table 4. Setup of II	scanner used	for the neutron	sensitivity	measurement

Value		
BAS SR (S/N 3804)		
FUJIFILM BAS 1800II S/N 462321		
50 μm		
16 bit		
4000		
5		

Fig. 3 (b) shows the IP data obtained after the neutron exposure. The tantalum disc and the fiber-optic face plate are optically thick for the x-ray and optically thin for the neutrons. Therefore the observed faint shadows of those materials are suggesting the phosphor excitation is dominated by the neutrons. The background level of the region covered with

the 1mm thick plastic disc got 3 times higher than that of surrounding regions. Typical neutron induced background under the fiber-optic faceplate was 560 PSL/mm^2 . The neutron fluence on the imaging plate was $4.3 \times 10^6 \text{ neutron/mm}^2$. Therefore the neutron sensitivity at 14 MeV is $1.3 \times 10^{-4} \text{ PSL/neutron}$. Figure 4 shows the observed background and the neutron fluence. The background scales linearly with the neutron fluence. The noise (the fluctuation of the background level in standard deviation) scales with square-root of the neutron fluence. This is consistent with a theoretical model that predicts the noise amplitude is determined by the statistical uncertainty of the neutron events in the spatial resolution elements.

Fig. 4. Neutron fluence vs. observed background and noise (standard deviation of the background).

MODELING OF THE NEUTRON SENSITIVITY

The mechanism of neutron detection is different from x-ray detection. X-ray photons are converted to electrons that then deposit their kinetic energy in the phosphor. In the case of neutrons, they produce energetic ions in the phosphor region via elastic recoil, (n,p), or (n,α) reactions. Then those energetic ions deposit energy in the phosphor region. Therefore it is important to understand the behavior of the energetic ions in the phosphor layer. In the case of 14 MeV neutron excitation, the stopping range of most recoiled particles is shorter than the thickness of the phosphor layer and they cannot escape. However protons produced by elastic recoil can have energy up to 14 MeV and some of them have enough energy to escape from the phosphor region. Therefore tracking of energetic proton in the phosphor is important. Figure 5 shows the result of numerical modeling and the experimental data. In order to calculate the energy deposition of the energetic protons, the numerical model used the results of MCNP5 [11] together with SRIM [12].

First of all, we prepared a hypothetical model of the phosphor which has no hydrogen atoms in the phosphor layer. Then energy deposition to the phosphor was calculated with the MCNP5 (tally type F6:n, track length estimate of heating). The generation and the slowdown of the recoiled protons were calculated by another 3D Monte Carlo code which based on a stopping-power table generated by SRIM. The total energy deposition to the phosphor was calculated by adding up those two calculations.

Figure 5 shows the result of sensitivity calculation. When the neutron energy is less than 1 MeV, the proton recoil in the phosphor layer is the dominant process of energy deposition. When neutron energy is more than 1 MeV, the escape of the recoiled protons becomes non-negligible. In the neutron energy region greater than 7.5 MeV, other processes (elastic recoil and (n,α) reaction of the heavy nucleus) are dominant. In the case of 14.1 MeV neutrons, the calculated average energy deposition per incident neutron is 1.3 keV (corresponds to 1.43×10^{-4} PSL/neutron when w = 4.125 MeV and L = $60\mu m$). The measured neutron sensitivity $(1.3 \times 10^{-4} \text{ PSL/neutron})$ is consistent with this Monte Carlo model.

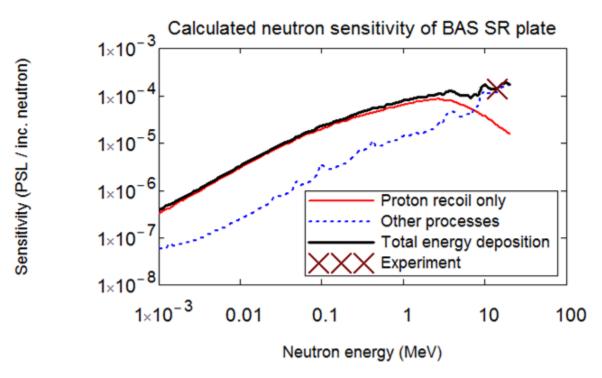


Fig. 5. Calculated neutron sensitivity of the imaging plate (BAS SR). The energy deposition due to proton recoil in the phosphor was calculated by a Monte Carlo code based on the SRIM2000. The energy deposition due to other mechanisms was calculated by the MCNP5. The calculated sensitivity was consistent with data at 14 MeV.

SUMMARY

X-ray and neutron sensitivities of the imaging plate (BAS SR) were measured. The observed x-ray sensitivity was 1.38×10^{-3} PSL/photon for 5.9 keV, 1.54×10^{-3} PSL/photon for 22 keV, and 0.89×10^{-3} PSL/photon for 59 keV. The neutron sensitivity was 1.4×10^{-4} PSL/neutron at 14.1 MeV. The observed x-ray and neutron sensitivity was consistent with a model incorporating MCNP and SRIM.

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REFERENCES

- [1] Y. Amemiya, et al., Nucl. Instrum. Methods Phys. Res. A 266, 645 (1988).
- [2] N. Izumi, R. Snavely, G. Gregori, et al., Rev. Sci. Instrum. 77, 10E325 (2006).
- [3] B. R. Maddox, et al., Rev. Sci. Instrum. 82, 023111 (2011).
- [4] N. Izumi, et al, Rev. Sci. Instrum. 83, 10E121 (2012).
- [5] T. Ma, et al, Rev. Sci. Instrum, 83, 10E115 (2012).
- [6] Y. Iwabuchi, et al., Jpn. J. Appl. Phys. **33**, 175 (1994).
- [7] J. S. Hendricks, et al., "MCNPX Version 26B," LA-UR-06-3248, Los Alamos National Laboratory (2006).
- [8] M. Thoms, Nucl. Instr. and Meth. in Phys. Res. A 378, 598 (1996).
- [9] J. M. Soures et al., Phys. Plasmas 3, 2108 (1996)
- [10] V. Yu. Glebov, et al., Rev. Sci. Instrum. **72**, 824 (2001).
- [11] X-5 Monte Carlo Team, LA-UR-03-1987. Los Alamos National Laboratory (revised 2008).
- [12] J.F. Ziegler, M.D. Ziegler and J.P. Biersack, SRIM-2008 Computer Code, Version SRIM-2008.03, 2008.